

<b>Notice of References Cited</b>	Application/Control No. 10/599,908		Applicant(s)/Patent Under Reexamination VAN DAM ET AL.	
	Examiner Pablo N. Tran		Art Unit 2618	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,064,665	05-2000	Leuck et al.	370/335
*	B	US-5,825,807	10-1998	Kumar, Derek D.	375/130
*	C	US-2007/0149147	06-2007	Kishimoto et al.	455/102
*	D	US-2006/0114815	06-2006	Hasegawa et al.	370/208
*	E	US-2005/0220051	10-2005	Lavean, Gil	370/330
*	F	US-7,406,261	07-2008	Shattil, Steve J	398/76
*	G	US-7,317,750	01-2008	Shattil, Steve J	375/146
*	H	US-6,141,332	10-2000	Lavean, Gil	370/335
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.